

Search Notes



Application/Control No.

10/695,197

Examiner

Nguyen T. Ha

Applicant(s)/Patent under
Reexamination

FUJIYAMA ET AL.

Art Unit

2831

SEARCHED

Class	Subclass	Date	Examiner
361	303	3/10/05	NH
	306.1		
	763		
	765		
	766		
	785		
439	70		
	71		
	342		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Fast Search.	3/10/05	NH
Consulted with Tommy Diul Class 361	3/10/05	NH